

	Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 07977-289001	Application No. 10/006,043
	Information Disclosure Statement by Applicant (Use several sheets if necessary)				Applicant Satoshi Murakami, et al.	
					Filing Date December 4, 2001	Group Art Unit 2814

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<i>NA</i>	AA	6,306,694 B1	10/23/2001	Yamazaki et al.	/		03/10/2000
	AB	6,737,304 B2	05/18/2004	Yamazaki et al.			10/10/2001
	AC	2002/0028543 A1	03/07/2002	Yamazaki et al.			10/10/2001
<i>NA</i>	AD	2004/0197971 A1	10/07/2004	Yamazaki et al.			04/26/2004
	AE				/		
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
<i>NA</i>	AL	2000-332256	11/30/2000	JAPAN	/		AB	
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
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Examiner Signature



Date Considered

10/11/05

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U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<i>NA</i>	AA	2001-0055841	12/27/2001	YAMAZAKI et al.			04/12/2001
	AB	2002-0068388	06/06/2002	MURAKAMI et al.			12/04/2001
	AC	2002-0153844	10/24/2002	KOYAMA			03/11/2002
	AD	4,792,210	12/20/1988	MAURICE			01/27/1987
	AE	5,234,541	08/10/1993	SHANNON et al.			05/29/1991
	AF	5,824,235	10/20/1988	YAMAZAKI et al.			07/29/1996
	AG	5,938,942	08/17/1999	YAMAZAKI et al.			07/13/1998
<i>NA</i>	AH	6,084,579	07/04/2000	HIRANO			11/25/1997
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
<i>NA</i>	AL	EP1 063 630	27 DEC 2000	EUROPE			In English	
	AM	JP2001-005426	12 JAN 2001	JAPAN			Abstract	
	AN	JP2002-057162	22 FEB 2002	JAPAN			Abstract	
<i>NA</i>	AO	JP-3281848	22 FEB 2002	JAPAN			Abstract	
	AP							

Other Documents (Include Author, Title, Date, and Place of Publication)

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Examiner Signature <i>John W. Allen</i>	Date Considered <i>10/11/05</i>
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